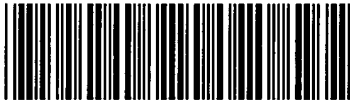


Search Notes

Application/Control No.

10/675,230

Examiner

John P. Sheehan

Applicant(s)/Patent under
Reexamination

NISHIZAWA ET AL.

Art Unit

1742

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| PG Pub | Search | 3/27/2007 | JPS |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---------------------------|------------|------|
| EAST | 12/10/2005 | JS |
| PALM Inventor Name Search | 12/10/2005 | JS |
| EAST | 6/13/2006 | JS |
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